

High Power Density 1W Laser Diode

Description

The SLD323V is a high power, gain-guided laser diode produced by MOCVD method^{*1}. Compared to the SLD300 Series, this laser diode has a high brightness output with a doubled optical density which can be achieved by QW-SCH structure^{*2}.

*1 MOCVD: Metal Organic Chemical Vapor Deposition

*2 QW-SCH: Quantum Well Separate Confinement Heterostructure

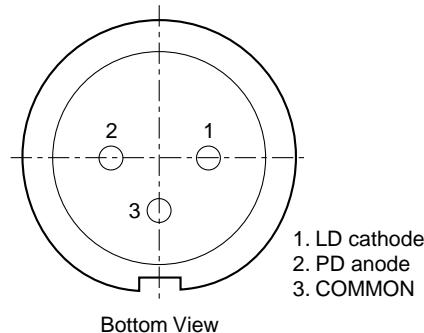
Features

- High power
Recommended optical power output: $P_o = 1.0W$
- Low operating current: $I_{op} = 1.4A$ ($P_o = 1.0W$)

Applications

- Solid state laser excitation
- Medical use
- Material processes
- Measurement

Pin Configuration



Structure

GaAlAs quantum well structure laser diode

Operating Lifetime

MTTF 10,000H (effective value) at $P_o = 1.0W$, $T_c = 25^\circ C$

Absolute Maximum Ratings ($T_c = 25^\circ C$)

| | | | |
|-----------------------------------|-----------|------------|----|
| • Optical power output | P_o | 1.1 | W |
| • Reverse voltage | V_R | LD | 2 |
| | | PD | 15 |
| • Operating temperature (T_c) | T_{opr} | -10 to +30 | °C |
| • Storage temperature | T_{stg} | -40 to +85 | °C |

Warranty

This warranty period shall be 90 days after receipt of the product or 1,000 hours operation time whichever is shorter.

Sony Quality Assurance Department shall analyze any product that fails during said warranty period, and if the analysis results show that the product failed due to material or manufacturing defects on the part of Sony, the product shall be replaced free of charge.

Laser diodes naturally have differing lifetimes which follow a Weibull distribution.

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Electrical and Optical Characteristics

(Tc: case temperature, Tc = 25°C)

| Item | Symbol | Conditions | Min. | Typ. | Max. | Unit |
|------------------------------------|---------------------------------|---|------|------|------|--------|
| Threshold current | I _{th} | | | 0.3 | 0.5 | A |
| Operating current | I _{op} | P _o = 1.0W | | 1.4 | 2.0 | A |
| Operating voltage | V _{op} | P _o = 1.0W | | 2.1 | 3.0 | V |
| Wavelength*1 | λ _p | P _o = 1.0W | 790 | | 840 | nm |
| Monitor current | I _{mon} | P _o = 1.0W V _R = 10V | 0.3 | 1.5 | 6.0 | mA |
| Radiation angle (F. W. H. M.*) | Perpendicular θ _⊥ | P _o = 1.0W | 20 | 30 | 40 | degree |
| | Parallel θ _{//} | | 4 | 9 | 17 | degree |
| Positional accuracy | Position ΔX, ΔY | P _o = 1.0W | | | ±50 | μm |
| | Angle Δφ _⊥ | | | | ±3 | degree |
| Differential efficiency | η _D | P _o = 1.0W | 0.5 | 0.9 | | W/A |

* F. W. H. M. : Full Width at Half Maximum

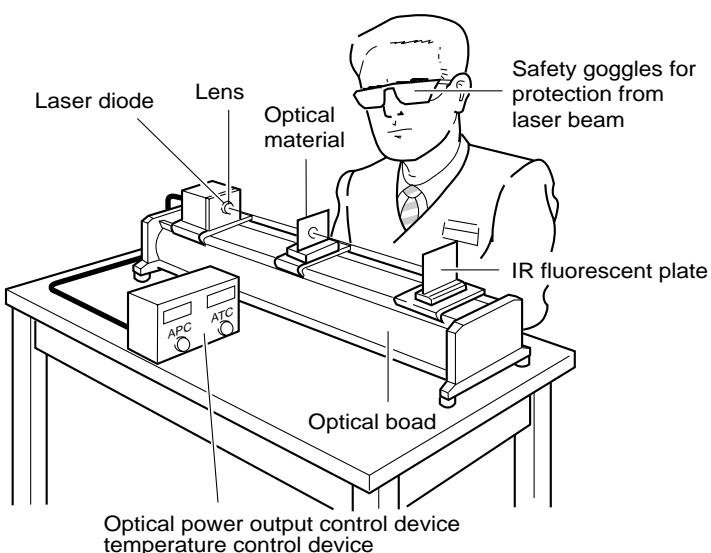
***1 Wavelength Selection Classification**

| Type | Wavelength (nm) |
|-----------|-----------------|
| SLD323V-1 | 795 ± 5 |
| SLD323V-2 | 810 ± 10 |
| SLD323V-3 | 830 ± 10 |

| Type | Wavelength (nm) |
|------------|-----------------|
| SLD323V-21 | 798 ± 3 |
| SLD323V-24 | 807 ± 3 |
| SLD323V-25 | 810 ± 3 |

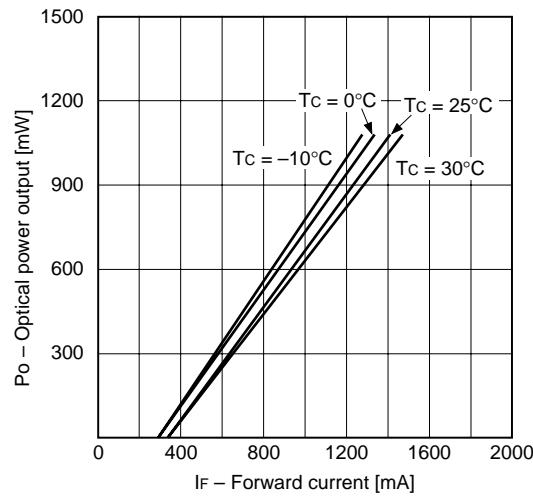
Handling Precautions**Eye protection against laser beams**

The optical output of laser diodes ranges from several mW to 3W. However the optical power density of the laser beam at the diode chip reaches 1MW/cm². Unlike gas lasers, since laser diode beams are divergent, uncollimated laser diode beams are fairly safe at a laser diode. For observing laser beams, ALWAYS use safety goggles that block infrared rays. Usage of IR scopes, IR cameras and fluorescent plates is also recommended for monitoring laser beams safely.

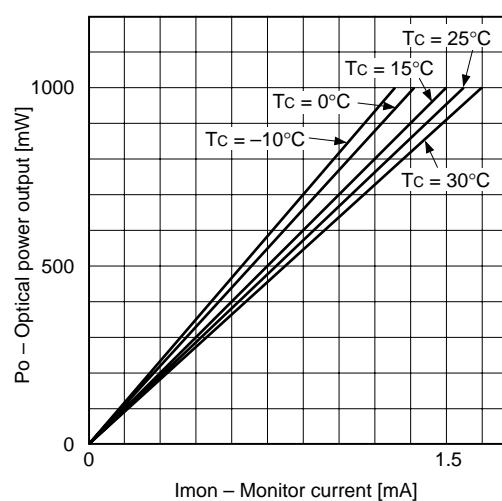


Example of Representative Characteristics

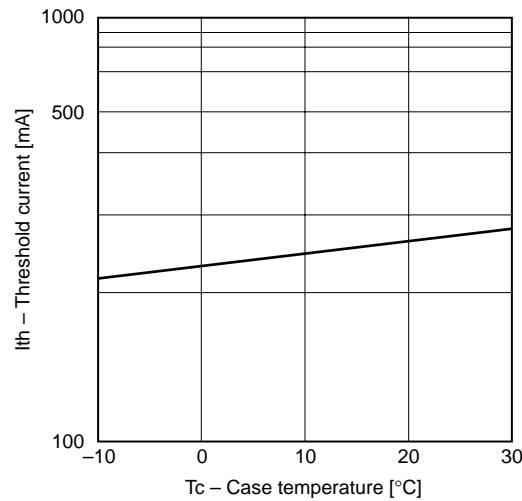
Optical power output vs. Forward current characteristics



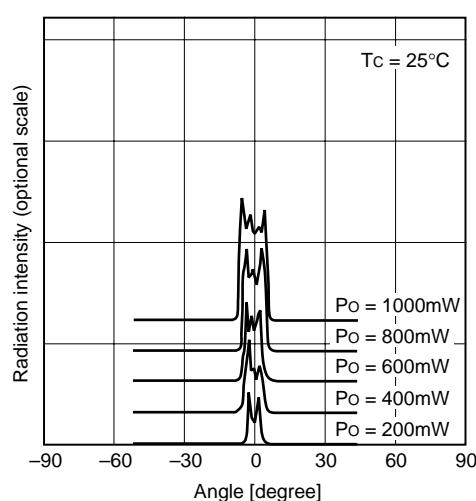
Optical power output vs. Monitor current characteristics



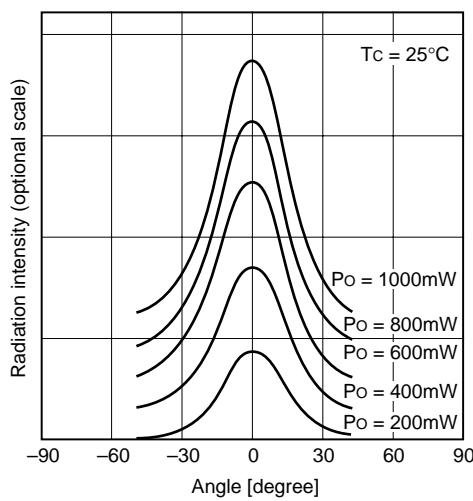
Threshold current vs. Temperature characteristics



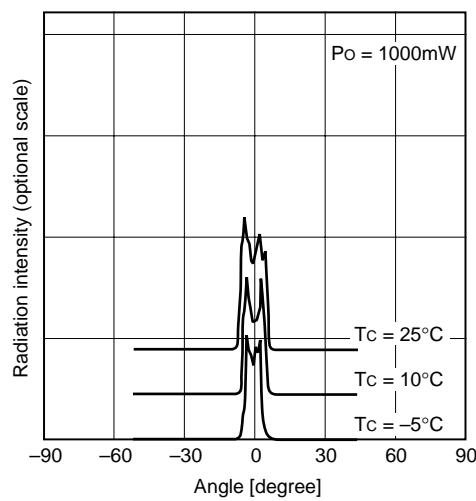
**Power dependence of far field pattern
(Parallel to junction)**



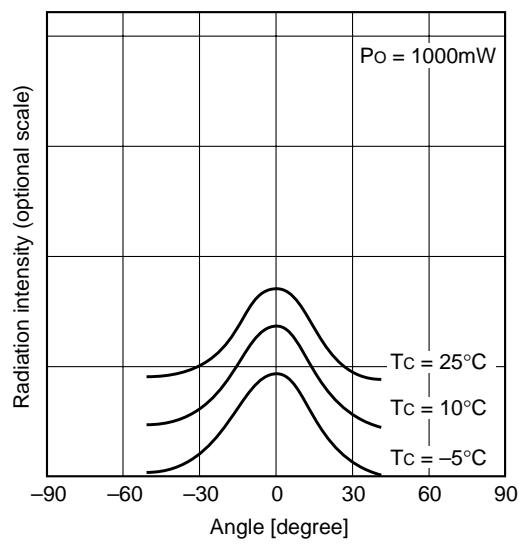
**Power dependence of far field pattern
(Perpendicular to junction)**



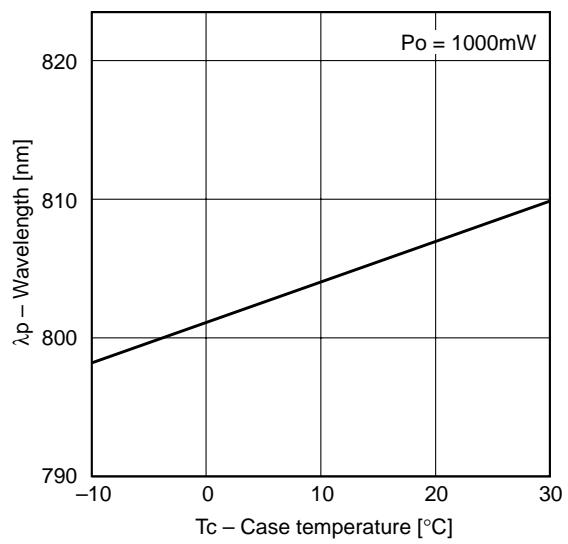
**Temperature dependence of far field pattern
(Parallel to junction)**



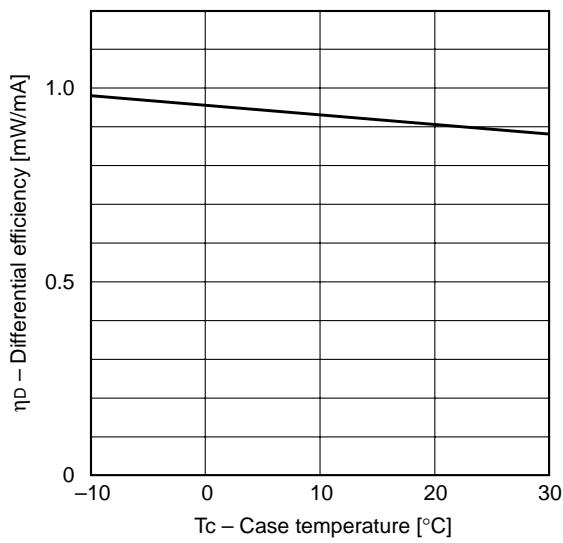
**Temperature dependence of far field pattern
(Perpendicular to junction)**

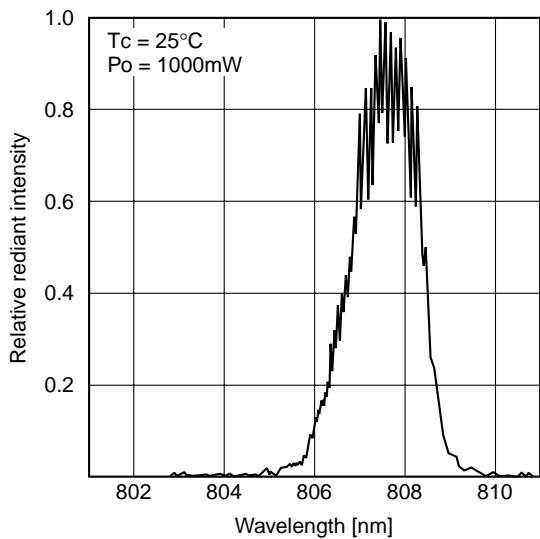
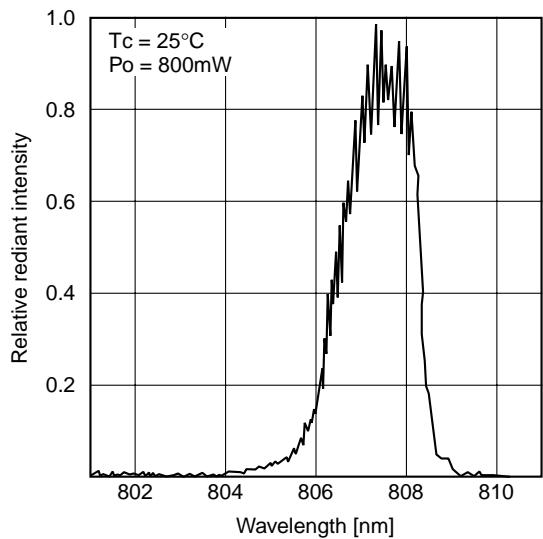
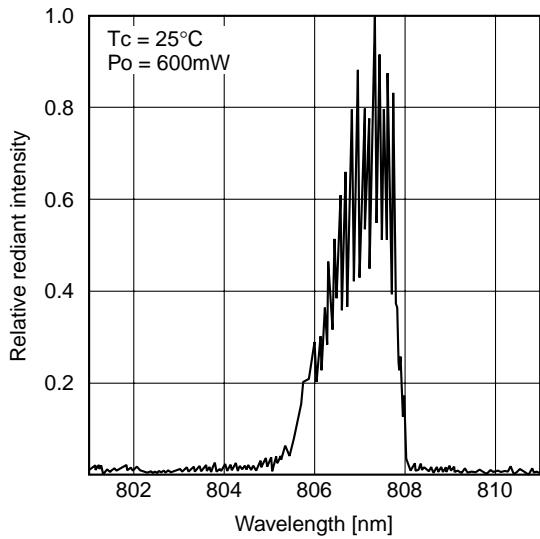
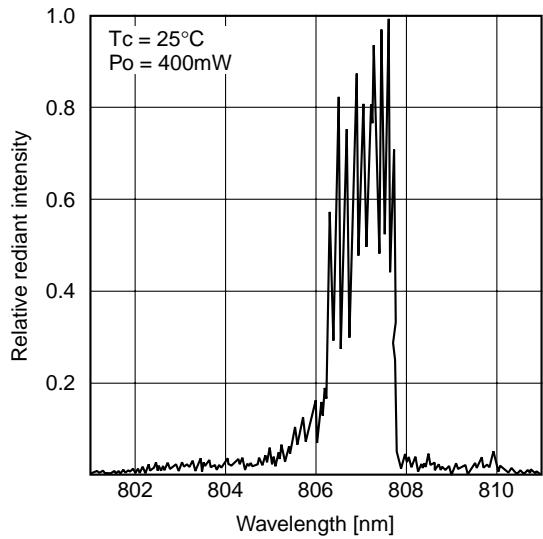


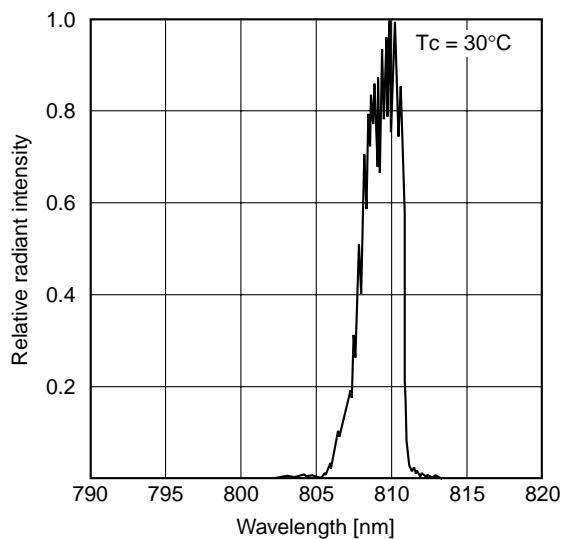
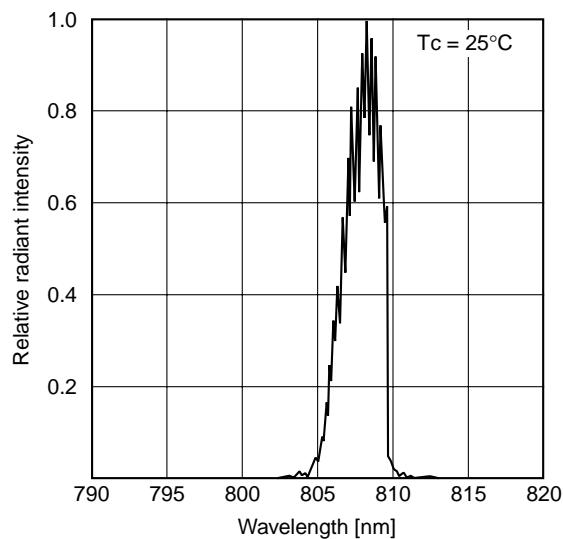
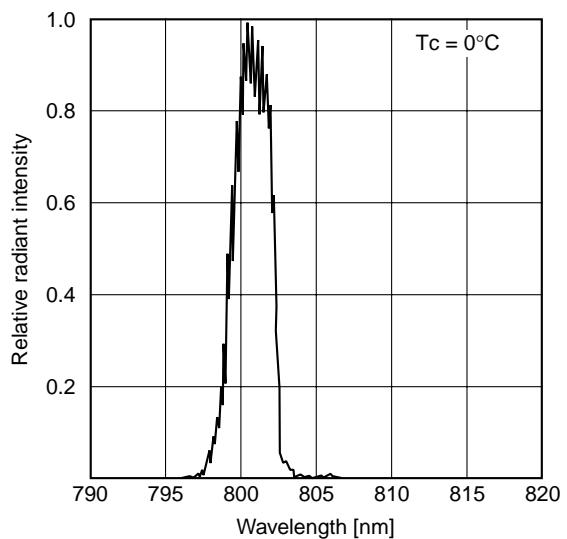
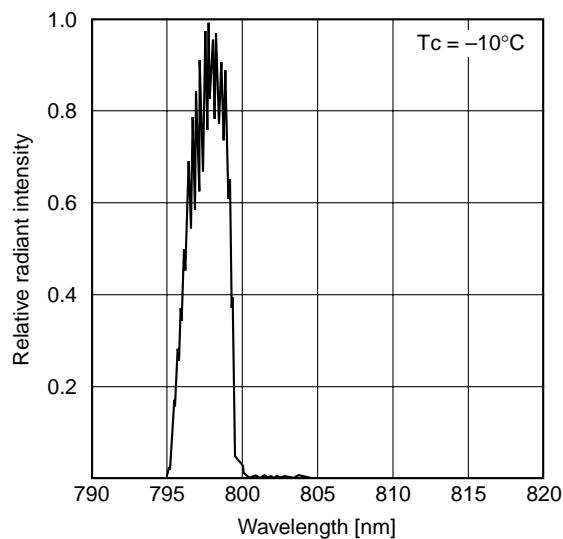
Dependence of wavelength



Differential efficiency vs. Temperature characteristics



Power dependence of spectrum

Temperature dependence of spectrum ($P_o = 1.0W$)

Package Outline

Unit: mm

M-248 (LO-11)

